

6th D/TOS-QCA Final Presentation Day 2004

## **SET Characterization of Parts for the ATV Project:**

IRFY140 Power MOSFET, LM185 Voltage Reference Diode and SMFL2805S DC-DC Converter

ESTEC Contract No. 13528/99/NL/MV, COO-16

**Hirex Engineering SAS** 

F.X. Guerre

**Estec Technical Officer** 

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Work performed under this contract:

Heavy ions testing using ATV actual application conditions

LM185Voltage Regulator DiodeIRFY140100V N-Channel MOSFET TransistorSMFL2805S28V Input DC/DC Converter

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## LM185 (1/9)

Part type:LM185Function:2-Terminal Bandgap Voltage Regulator DiodeManufacturer:National SemiconductorPackage:TO-46Quality Level:Hi-RelDate Code:0134Detail specification:SMD 5962-8759402XA (WE5000017484)Die Marking:G185CDie dimensions:1.47 mm x 1.29 mm





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LM185 (2/9)

# Bias Conditions As per ATV-RIBRE-DFX-0281-03, EADS fax dated 22/08/03, page 2



Oscilloscope:1MOhm Input, trigger level: Vdut +/- 50mV

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LM185 (3/9)

BNL Tandem Van de Graaff accelerator

2004-01-17

lon	<b>Energy</b> Me∨	LET(Si) Mev/(mg/cm <sup>2</sup> )	<b>Range (Si)</b> µm	
F-19	140	3.38	120.4	
CI-35	199	11.73	59.41	
Ni-58	265	26.58	42.23	
Au-197	333	81.44	27.53	



LM185 (4/9)

## RESULTS

Preliminary runs show that only negative events occurred but with a possible positive overshoot:

→ trigger level was fixed to -50mV for all runs.

DUT output voltage slightly out of specification: further verification showed that die was light sensitive

### **SET waveforms**

•Negative Pulse:

Worst case: amplitude 400mV, FWHM 20µs

•Overshoot Pulse:

Worst case: amplitude 200mV, FWHM 40µs





#### LM185 (5/9)



Trigger level -50mV



LM185 (6/9)



•LET of 26.58 • Worst case negative SET

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LM185 (7/9)







LM185 (8/9)



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LM185 (9/9)







## IRFY140 (1/5)

Part type:IRFY140Function:100V N-Channel MOSFET TransistorManufacturer:International RectifierPackage:TO-257AQuality Level:Hi-RelDate Code:9730Detail specification:MA5000AKG01SDie marking:-Die dimensions:4.3 mm x 4.8 mm





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IRFY140 (2/5)

Bias Conditions As per ATV/MMS/PR/FX/329.03 EADS fax dated 30/07/03

VDS =30V VGS=-4V

Test Set-up allows for detecting and counting:

SEB (non destructive burn-out by limiting the energy) SEGR (gate current monitoring)

Upon completion of each run (beam off), device operation is tested at nominal specified VDS (100V)



## IRFY140 (3/5)



HIREL EXPERTISE

## **SET Characterization of Parts for the ATV Project:**

IRFY140 (4/5)

 BNL Tandem Van de Graaff accelerator
 2004-01-17

lon	<b>Energy</b>	LET(Si)	Range (Si)	
	MeV	Mev/(mg/cm²)	µm	
Br-81	279	37.45	36.09	



## IRFY140 (5/5)

#### Beam data

Run	S/N	LET(Si)	Tilt	Roll	Time	Flux	Fluence	Dose	TotalDose
#	#	MeV.cm2/mg	deg	deg	sec	#/cm2/sec	#/cm2	RAD(Si)	RAD(Si)
1	5	37.45	0	0	581	9.16E+03	5.32E+06	3.01E+03	3.01E+03
2	3	37.45	0	0	578	8.65E+03	5.00E+06	3.01E+03	3.01E+03
3	3	37.45	0	0	586	8.54E+03	5.00E+06	3.01E+03	6.03E+03
4	3	37.45	0	0	443	1.18E+04	5.23E+06	3.01E+03	9.04E+03
5	5	37.45	0	0	406	1.23E+04	5.00E+06	3.02E+03	6.03E+03

#### IRFY140 results

						Test	Test
Run	S/N	LET(Si)	Fluence	<b>Events</b>	<b>Events</b>	Cond	Cond
#	#	MeV.cm2/mg	#/cm2	SEB	SEGR	Vds (V)	Vgs (V)
1	5	37.45	5.32E+06	0	0	30	-4
2	3	37.45	5.00E+06	0	0	30	-4
3	3	37.45	5.00E+06	0	0	40	-4
4	3	37.45	5.23E+06	0	0	50	-4
5	5	37.45	5.00E+06	0	0	50	-4

#### No SEB nor SEGR detected with ATV test conditions





SMFL2805S (1/8)

Part type: Function: Manufacturer: Package: Quality Level: Date Code: SMFL2805S 28V Input DC/DC Converter Interpoint Specific hermetic (U style) Hi-Rel (ATV flight parts) 0347





SET Characterization of Parts for the ATV Project: SMFL2805S (2/8)





Beam spot diameter is 23 mm

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SMFL2805S (3/8)

## Bias Conditions As per ATV-RIBRE-DFX-0049-03, Astrium fax dated 14/02/03 Input voltage range: 28 VDC ± 4 VDC Nominal output load: 25 W





SMFL2805S (4/8)

# UCL Cyclotron accelerator

2004 -03 -11

lon	<b>Energy</b> Me∨	<b>LET(Si)</b> Mev/(mg/cm²)	<b>Range (Si)</b> μm
Ne-20	78	5.85	45
Ar-40	150	14.1	42
Kr-84	316	34	43



## SMFL2805S (5/8)

## RESULTS

Both positive and negative transient pulses were detected with a trigger level fixed to +/- 50 mV around DUT output voltage.

•Krypton (LET 34)	Both positive and negative events with exposed areas A1, A2 and A3
•Argon (LET 14)	Negative Events only with exposed areas A1 and A2
•Neon (LET 5.85)	No Event detected

# **SET waveforms**

Negative Pulse: Worst case: amplitude 180mV, FWHM 20µs

Positive Pulse:

Worst case: amplitude 90mV, FWHM 50µs



## SMFL2805S (6/8)





## SMFL2805S (7/8)





## SMFL2805S (8/8)

SET Error X-section (cm <sup>2</sup> )						
		Kr (34)	Ar (14)	Ne (5.85)		
A.1	+50m∨	1.98E-04	20 - 20 	- -		
	-50mV	2.96E-04	5.00E-05	-		
۸2	+50m∨	1.46E-04	-	-		
R2	-50mV	3.58E-04	3.60E-05	-		
A3	+50m∨	3.43E-05	20 - 20 	-		
	-50mV	1.16E-04		-		
A4	+50m∨	-	-	-		
	-50mV	-	-	-		